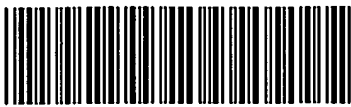
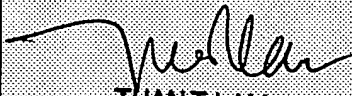



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/813,129	HIRAMATSU ET AL.	
	Examiner	Art Unit	
	Hiep Nguyen	2816	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
327	143			327	198	63				
INTERNATIONAL CLASSIFICATION										
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HIEP NGUYEN 04-28-05 (Assistant Examiner) (Date)				 TUAN T. LAM PRIMARY EXAMINER (Primary Examiner)				Total Claims Allowed: 15		
 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1		O.G. Print Fig. 1
				5/16/05				(Date)		

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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